

Search Notes

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Examiner

Son L. Mai

Applicant(s)/Patent under
Reexamination

CHOI ET AL.

Art Unit

2827

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB) (see search history printouts)	11/18/2005	SM